

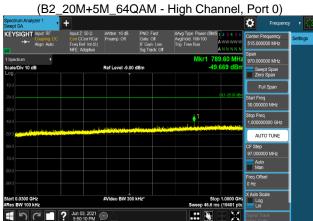


Plot 7-2025. Conducted Spurious Emission Plot 150 kHz to 30 MHz

(B2_20M+5M_QPSK - High Channel, Port 0)

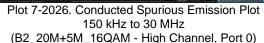


Plot 7-2027. Conducted Spurious Emission Plot 150 kHz to 30 MHz



Plot 7-2029. Conducted Spurious Emission Plot 30 MHz to 1 GHz (B2_20M+5M_QPSK - High Channel, Port 0)







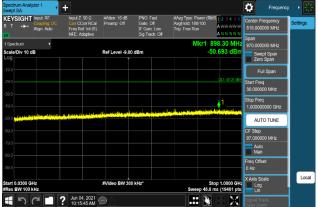
Plot 7-2028. Conducted Spurious Emission Plot 150 kHz to 30 MHz



Plot 7-2030. Conducted Spurious Emission Plot 30 MHz to 1 GHz (B2_20M+5M_16QAM - High Channel, Port 0)

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Plot 7-2031. Conducted Spurious Emission Plot 30 MHz to 1 GHz

(B2_20M+5M_64QAM - High Channel, Port 0)



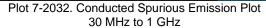
Plot 7-2033. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz

(B2_20M+5M_QPSK - High Channel, Port 0)



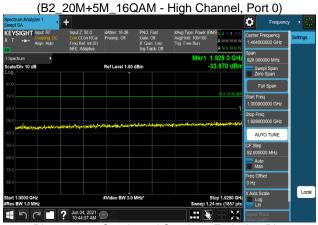
Plot 7-2035. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz (B2_20M+5M_64QAM - High Channel, Port 0)







Plot 7-2034. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz



Plot 7-2036. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz (B2_20M+5M_256QAM - High Channel, Port 0)

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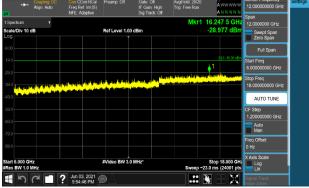
Plot 7-2037. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz

(B2_20M+5M_QPSK - High Channel, Port 0)



Plot 7-2039. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz

(B2_20M+5M_64QAM - High Channel, Port 0)



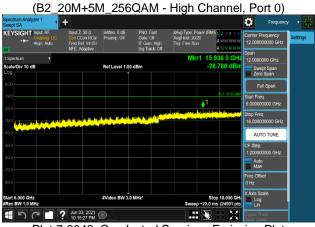
Plot 7-2041. Conducted Spurious Emission Plot 6 GHz to 18 GHz (B2_20M+5M_QPSK - High Channel, Port 0)

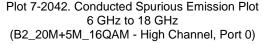


Plot 7-2038. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz (B2_20M+5M_16QAM - High Channel, Port 0)



Plot 7-2040. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz





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Plot 7-2043. Conducted Spurious Emission Plot 6 GHz to 18 GHz

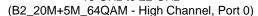
(B2_20M+5M_64QAM - High Channel, Port 0)



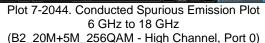
Plot 7-2045. Conducted Spurious Emission Plot 18 GHz to 22 GHz

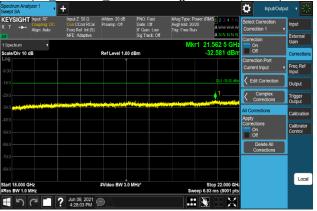


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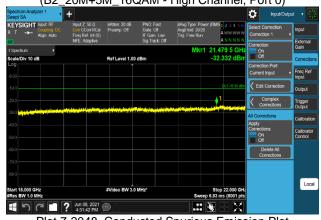








Plot 7-2046. Conducted Spurious Emission Plot 18 GHz to 22 GHz (B2 20M+5M 16QAM - High Channel, Port 0)



Plot 7-2048. Conducted Spurious Emission Plot 18 GHz to 22 GHz (B2_20M+5M_256QAM - High Channel, Port 0)

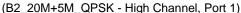
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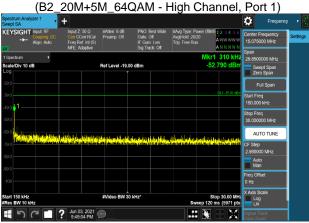


Plot 7-2049. Conducted Spurious Emission Plot 9 kHz to 150 kHz



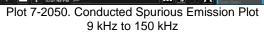


Plot 7-2051. Conducted Spurious Emission Plot 9 kHz to 150 kHz



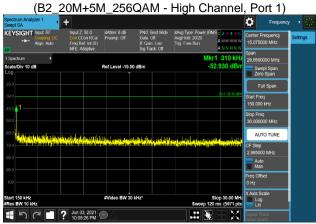
Plot 7-2053. Conducted Spurious Emission Plot 150 kHz to 30 MHz (B2_20M+5M_QPSK - High Channel, Port 1)







Plot 7-2052. Conducted Spurious Emission Plot 9 kHz to 150 kHz



Plot 7-2054. Conducted Spurious Emission Plot 150 kHz to 30 MHz (B2_20M+5M_16QAM - High Channel, Port 1)

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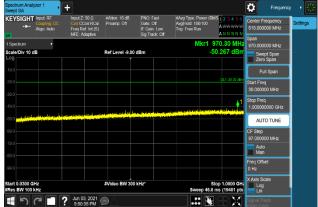
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Plot 7-2055. Conducted Spurious Emission Plot 150 kHz to 30 MHz

(B2_20M+5M_64QAM - High Channel, Port 1)



Plot 7-2057. Conducted Spurious Emission Plot 30 MHz to 1 GHz

(B2_20M+5M_QPSK - High Channel, Port 1)



Plot 7-2059. Conducted Spurious Emission Plot 30 MHz to 1 GHz (B2_20M+5M_64QAM - High Channel, Port 1)



Plot 7-2056. Conducted Spurious Emission Plot 150 kHz to 30 MHz



Plot 7-2058. Conducted Spurious Emission Plot 30 MHz to 1 GHz



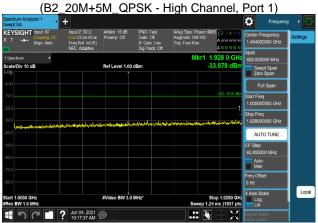
Plot 7-2060. Conducted Spurious Emission Plot 30 MHz to 1 GHz (B2_20M+5M_256QAM - High Channel, Port 1)

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Plot 7-2061. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz

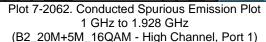


Plot 7-2063. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz (B2_20M+5M_64QAM - High Channel, Port 1)



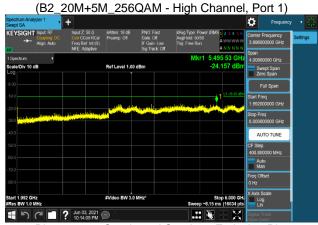
Plot 7-2065. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz (B2_20M+5M_QPSK - High Channel, Port 1)







Plot 7-2064. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz



Plot 7-2066. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz (B2_20M+5M_16QAM - High Channel, Port 1)

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Plot 7-2067. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz

(B2_20M+5M_64QAM - High Channel, Port 1)



Plot 7-2069. Conducted Spurious Emission Plot 6 GHz to 18 GHz

(B2_20M+5M_QPSK - High Channel, Port 1)



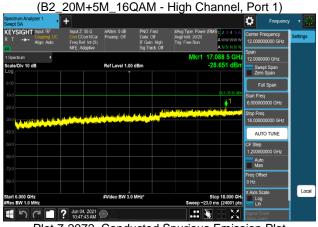
Plot 7-2071. Conducted Spurious Emission Plot 6 GHz to 18 GHz (B2_20M+5M_64QAM - High Channel, Port 1)



Plot 7-2068. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz



Plot 7-2070. Conducted Spurious Emission Plot 6 GHz to 18 GHz

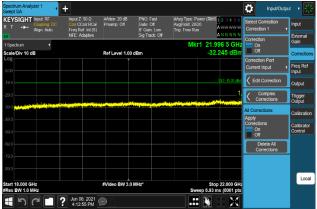


Plot 7-2072. Conducted Spurious Emission Plot 6 GHz to 18 GHz (B2_20M+5M_256QAM - High Channel, Port 1)

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Plot 7-2073. Conducted Spurious Emission Plot 18 GHz to 22 GHz

(B2_20M+5M_QPSK - High Channel, Port 1)

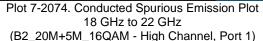


Plot 7-2075. Conducted Spurious Emission Plot 18 GHz to 22 GHz



Plot 7-2077. Conducted Spurious Emission Plot 9 kHz to 150 kHz (B2_20M+5M_QPSK - High Channel, Port 2)

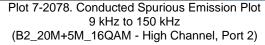






Plot 7-2076. Conducted Spurious Emission Plot 18 GHz to 22 GHz





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Plot 7-2079. Conducted Spurious Emission Plot 9 kHz to 150 kHz

(B2_20M+5M_64QAM - High Channel, Port 2)



Plot 7-2081. Conducted Spurious Emission Plot 150 kHz to 30 MHz

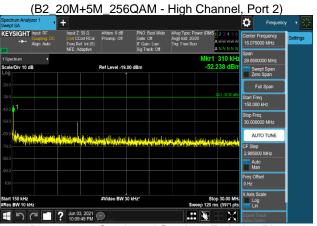
(B2_20M+5M_QPSK - High Channel, Port 2)



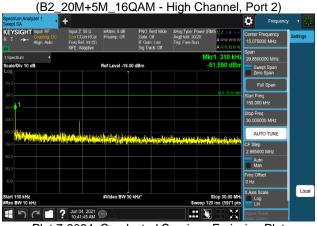
Plot 7-2083. Conducted Spurious Emission Plot 150 kHz to 30 MHz (B2_20M+5M_64QAM - High Channel, Port 2)



Plot 7-2080. Conducted Spurious Emission Plot 9 kHz to 150 kHz



Plot 7-2082. Conducted Spurious Emission Plot 150 kHz to 30 MHz



Plot 7-2084. Conducted Spurious Emission Plot 150 kHz to 30 MHz (B2_20M+5M_256QAM - High Channel, Port 2)

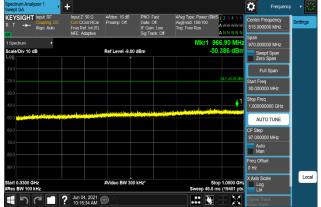
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Plot 7-2085. Conducted Spurious Emission Plot 30 MHz to 1 GHz

(B2_20M+5M_QPSK - High Channel, Port 2)



Plot 7-2087. Conducted Spurious Emission Plot 30 MHz to 1 GHz

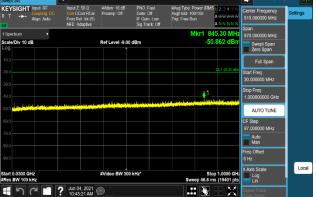
(B2_20M+5M_64QAM - High Channel, Port 2) Ö Frequ KEYSIGHT AUTO TUNE Auto Man BW 3.0 MH art 1.0000 GHz Res BW 1.0 MHz Stop 1.9280 GH Sweep 1.24 ms (1857 pt 1 つ つ の Jun 03, 2021 9:52:21 PM

Plot 7-2089. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz (B2_20M+5M_QPSK - High Channel, Port 2)

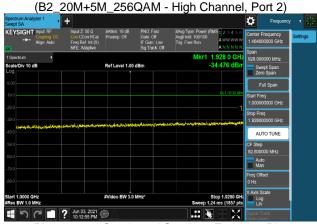


Plot 7-2086. Conducted Spurious Emission Plot 30 MHz to 1 GHz

(B2_20M+5M_16QAM - High Channel, Port 2) Ö Free



Plot 7-2088. Conducted Spurious Emission Plot 30 MHz to 1 GHz



Plot 7-2090. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz (B2_20M+5M_16QAM - High Channel, Port 2)

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Plot 7-2091. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz

(B2_20M+5M_64QAM - High Channel, Port 2)



Plot 7-2093. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz

(B2_20M+5M_QPSK - High Channel, Port 2)



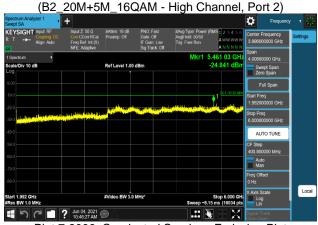
Plot 7-2095. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz (B2_20M+5M_64QAM - High Channel, Port 2)



Plot 7-2092. Conducted Spurious Emission Plot 1 GHz to 1.928 GHz (B2_20M+5M_256QAM - High Channel, Port 2)



Plot 7-2094. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz



Plot 7-2096. Conducted Spurious Emission Plot 1.992 GHz to 6 GHz (B2_20M+5M_256QAM - High Channel, Port 2)

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